

**Search Notes**

Application/Control No.

10/606,382

Examiner

VAN T. PHAM

Applicant(s)/Patent under  
Reexamination

LEE, GAB JAE

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
369	116, 53.26.	12/1/2005 updated on 5/7/06	VP VP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB)  369, 385 (text search only see search history printout).	5/7/2006	VP